line 15, delete "the" (second occurrence) and insert --a--.

Page 17, line 8, delete "or laser" and insert -- (mechanical or laser)--.

IN THE CLAIMS:

1. (Amended) A process for manufacturing a semiconductor device comprising [the] steps of:

defining a [number] <u>plurality</u> of semiconductor chip sections on a wafer, each semiconductor chip section having a [number] <u>plurality</u> of chip electrodes formed on one surface along a periphery thereof, the one surface being covered with a passivating film except for [the] positions where the chip electrodes are formed;

forming a number of interconnection layers on the wafer for each semiconductor chip section such that each interconnection layer is connected to the chip electrode at [one] a first end thereof and is extended inwardly toward the chip section at [the other] a second end,

covering [the] an entire surface of the wafer with a cover coating film; forming a [number] plurality of apertures in the cover coating film, the apertures being formed into a matrix;

simultaneously forming a [number] plurality of bumps on the respective apertures; and

separating the semiconductor chip sections on the wafer as individual semiconductor chips along scribe lines.

- 2. (Amended) A process for manufacturing a semiconductor device as claimed in claim 1, wherein the interconnection layer is extended inwardly at a position where the semiconductor chip section is exposed to the atmosphere through the aperture.
- 4. (Amended) A process for manufacturing a semiconductor device as claimed in claim 1, wherein the bumps are formed at the position except for [just] over the chip electrodes.

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5. (Amended) A semiconductor wafer having a [number] plurality of semiconductor chips, comprising:

bump electrodes <u>simultaneously</u> formed into a matrix on an entire surface of the wafer except for on scribe lines between the semiconductor chips.

6. (Amended) A process for manufacturing a semiconductor device having a [number] <u>plurality</u> of chip electrodes, a [number] <u>plurality</u> of bump electrodes, and interconnecting layers for <u>respectively</u> electrically connecting the chip electrodes and the bump electrodes, the process comprising [the] steps of:

providing a wafer having a [number] plurality of chip sections defined thereon by scribe lines, each chip section having the chip electrodes formed thereon;

providing the interconnection layers such that each interconnection layer is connected to the chip electrode at [one] <u>a first</u> end thereof and [the other] <u>a second</u> end of the interconnection layer is extended towards [the] <u>a</u> central portion of the chip section;

applying a coating film over [the] <u>an</u> entire surface of the wafer and the interconnection layers;

forming a [number] a plurality of apertures in the coating film passing therethrough;

simultaneously forming the bump electrodes at [the] a position corresponding to the apertures; and

separating the chip sections from each other along the scribe lines.

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9. (Amended) A process for manufacturing a semiconductor device as claimed in claim 6, wherein the bump electrodes are located at positions other than [the place just] over the chip electrodes.

10. (Amended) A semiconductor wafer including:

[having] a [number] plurality of chip sections defined thereon by scribe